

<b>Notice of References Cited</b>	Application/Control No. 09/854,219	Applicant(s)/Patent Under Reexamination YAMADA ET AL.	
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	V	KANAI et al., T. Metamorphosis of Arbitrary Triangular Meshes, IEEE, Computer Graphics and Applications, Vol. 20, No. 2, March-April 2000, pages 62-75.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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